

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	352	(measur\$3 near6 (film near3 substrate)).clm.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/18 17:12
L2	0	1 and (subset near4 regions).clm.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/18 17:03
L3	0	1 and (subset near6 regions).clm.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/18 17:04
L4	83	1 and (compar\$3 near9 measur\$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/18 17:04
L5	20	4 and (defect or (critical near dimension))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/18 17:04
L6	1018	film near5 substrate and (plurality near3 (region near3 film))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/18 17:11
L7	1641	film near5 substrate and (plurality near3 ((regions or patterns) near3 film))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/18 17:11
L8	19	6 and (detect\$3 or measur\$3) near9 (patterns near6 film)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/18 17:11
L9	73	7 and (detect\$3 or measur\$3) near9 (patterns near6 film)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/18 17:11
L10	77	1 and (defect or (critical near dimension))".clm"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/18 17:12

L11	77	1 and (defect or (critical near dimension))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/18 17:16
L12	0	6 and (imprint near head).clm.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/18 17:16
L13	22	(imprint near head).clm.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/18 17:22
L14	111	Molecular near Imprints near inc	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/18 17:22
L15	44	14 and imprint near2 head	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/18 17:22